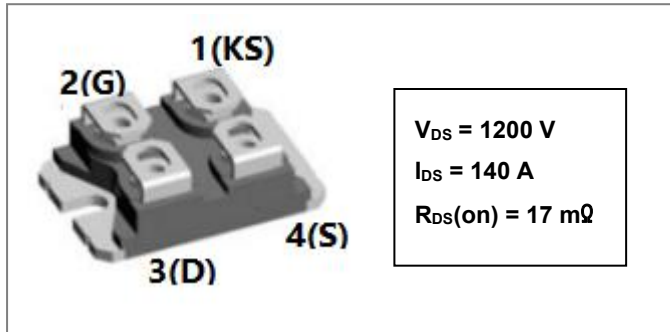


# S2M0016120N

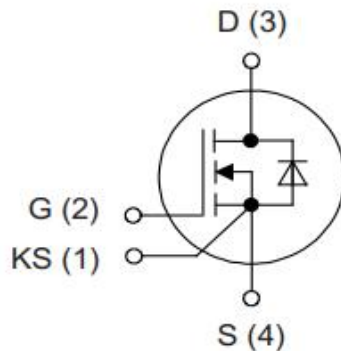
## 1200V SiC POWER MOSFET



### Description

S2M0016120N is single SiC Power MOSFET packaged in SOT-227 case. The device is a high voltage n-channel enhancement mode MOSFET that has very low total conduction losses and very stable switching characteristics over temperature extremes. The S2M0016120N is ideal for energy sensitive, high frequency applications in challenging environments.

### Circuit Diagram



### Features

- Positive temperature characteristics, easy to parallel.
- Low on-resistance Typ. RDS(on) = 17mΩ .
- Fast switching speed and low switching losses.
- Very fast and robust intrinsic body diode.

### Applications

- EV Fast Charging Modules
- EV On Board Chargers
- Solar Inverters
- Online UPS/Industrial UPS
- SMPS (Switch Mode Power Supplies)
- DC-DC Converters
- ESS (Energy Storage Systems)

### Maximum Ratings(T=25°C unless otherwise specified)

Characteristics	Symbol	Condition	Max.	Units
Drain Source Voltage	V <sub>DSS</sub>	V <sub>GS</sub> = 0V, I <sub>DS</sub> = 100uA, T <sub>C</sub> = 25°C	1200	V
Gate Source Voltage	V <sub>GSS</sub>	T <sub>C</sub> = 25°C, Absolute maximum values, AC (f>1Hz)	-10 to +25	V
Gate Source Voltage	V <sub>GSOP</sub>	T <sub>C</sub> = 25°C Recommended Operational Values	-5 to +20	V
Continuous Drain Current	I <sub>D</sub>	V <sub>GS</sub> = 20V, T <sub>C</sub> = 25°C	140	A
		V <sub>GS</sub> = 20V, T <sub>C</sub> = 100°C	99	A
Pulsed Drain Current	I <sub>D,pulse</sub>	T <sub>C</sub> =25°C	250	A
Power Dissipation	P <sub>D</sub>	T <sub>C</sub> =25°C	517	W
SOT-227 Mounting Torque		M4 Screw	1	Nm

**Electrical Characteristics(T=25°C unless otherwise specified)**

Characteristics	Symbol	Condition	Min.	Typ.	Max.	Units
Drain Source Breakdown Voltage	$V_{(BR)DSS}$	$V_{GS} = 0V, I_D = 100\mu A$	1200			V
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}, I_D = 23mA$	1.8	2.55	3.6	V
		$V_{DS} = V_{GS}, I_D = 23mA, T_J = 175^\circ C$		1.85		V
Zero Gate Voltage Drain Current	$I_{DSS}$	$V_{DS} = 1200V, V_{GS} = 0V$		1	10	$\mu A$
Gate Source Leakage Current	$I_{GSS}$	$V_{GS} = 20V, V_{DS} = 0V$		10	250	nA
Drain Source On-State Resistance	$R_{DS(on)}$	$V_{GS} = 20V, I_D = 75A$	11.2	17	23	m $\Omega$
		$V_{GS} = 18V, I_D = 75A$		19		m $\Omega$
		$V_{GS} = 20V, I_D = 75A, T_J = 175^\circ C$		28		m $\Omega$
		$V_{GS} = 18V, I_D = 75A, T_J = 175^\circ C$		29		m $\Omega$
Transconductance	gfs	$V_{DS} = 20V, I_D = 75A$		24		S
		$V_{DS} = 20V, I_D = 75A, T_J = 175^\circ C$		18		S
Input Capacitance	$C_{ISS}$	$V_{GS} = 0V,$		4540		pF
Output Capacitance	$C_{OSS}$	$V_{DS} = 1000V$		210		
Reverse Transfer Capacitance	$C_{RSS}$	$V_{AC} = 25mV$		29.3		
Coss Stored Energy	$E_{OSS}$	$f = 100kHz$		122		$\mu J$
Turn-On Switching Energy	$E_{ON}$	$V_{DS} = 800V, V_{GS} = -5/+20V$ $I_D = 75A, R_{G(ext)} = 2.5\Omega$		0.44		mJ
Turn-Off Switching Energy	$E_{OFF}$	$L = 65.7\mu H, T_J = 25^\circ C$		0.44		
Turn-On Delay Time	$t_{d(on)}$	$V_{DS} = 800V, V_{GS} = -5/20V$		13.76		ns
Rise Time	$t_r$	$I_D = 75A, R_{G(ext)} = 2.5\Omega, L = 67.5\mu H$		21.12		
Turn-Off Delay Time	$t_{d(off)}$	Inductive Load Timing relative to VDS Per IEC60747-8-4 pg 83		33.92		
Fall Time	$t_f$			8.96		
Internal Gate Resistance	$R_{G(int)}$	$f = 1MHz, V_{AC} = 25mV, D-S$ short		1.5		$\Omega$
Gate to Source Charge	$Q_{gs}$	$V_{DS} = 800V, V_{GS} = -5/20V$		290		nC
Gate to Drain Charge	$Q_{gd}$	$I_D = 75A$		37.2		
Total Gate Charge	$Q_g$			285		

**Reverse Diode Characteristics:**

Characteristics	Symbol	Condition	Typ.	Max.	Units
Diode Forward Voltage	$V_{SD}$	$V_{GS} = -5V, I_{SD} = 37.5A$	3.5		V
	$V_{SD}$	$V_{GS} = -5V, I_{SD} = 37.5A, T_J = 175^\circ C$	3.0		V
Continuous Diode Forward Current	$I_S$	$V_{GS} = -5V, T_C = 25^\circ C$		112	A
Reverse Recovery Time	$t_{rr}$	$V_{GS} = -5V, I_{SD} = 75A, T_J = 175^\circ C$	15		ns
Reverse Recovery Charge	$Q_{rr}$		$V_R = 800V$	201	
Peak Reverse Recovery Current	$I_{mm}$	$diff/dt = 2664A/\mu s$	21		A

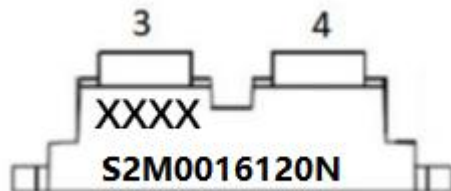
**Thermal-Mechanical Specifications:**

Characteristics	Symbol	Condition	Specification	Units
Junction Temperature	$T_J$	-	-55 to +175	$^\circ C$
Storage Temperature	$T_{stg}$	-	-55 to +175	$^\circ C$
Typical Thermal Resistance Junction to Case	$R_{\theta JC}$	DC operation	0.29	$^\circ C/W$

**Ordering Information:**

Device	Package	Shipping
S2M0016120N	SOT-227	36pcs /BULK

**Marking Diagram**



Where XXXXX is YYWWL

- S2M = Device Type
- 0016 =  $R_{DS(on)}$
- 120 = Reverse Voltage (1200V)
- N = Package
- SSG = SSG
- YY = Year
- WW = Week
- L = Lot Number

**Cautions:** Molding resin  
Epoxy resin UL:94V-0

**Ratings and Characteristics Curves**

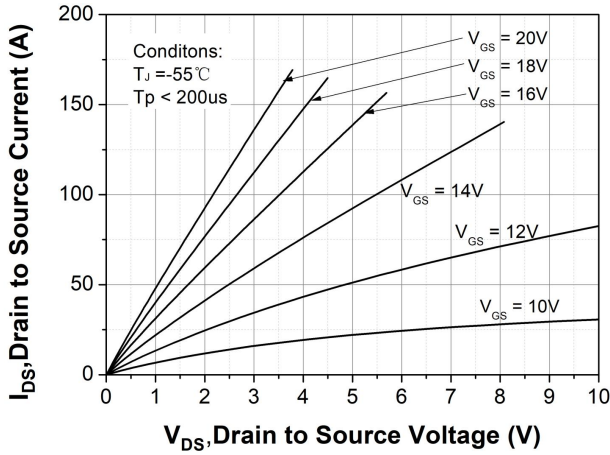


Figure 1. Output Characteristics  $T_J = -55^\circ\text{C}$

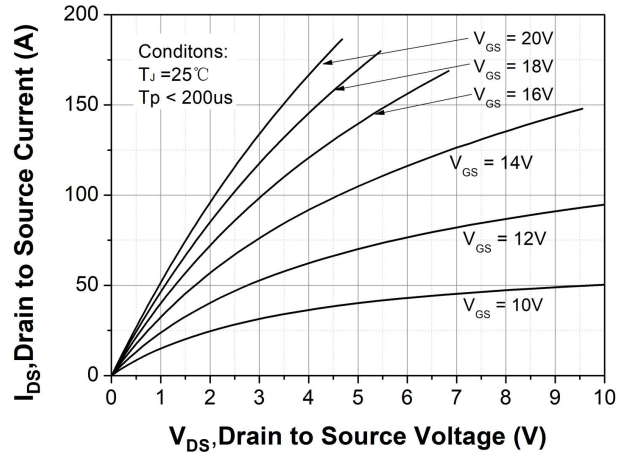


Figure 2. Output Characteristics  $T_J = 25^\circ\text{C}$

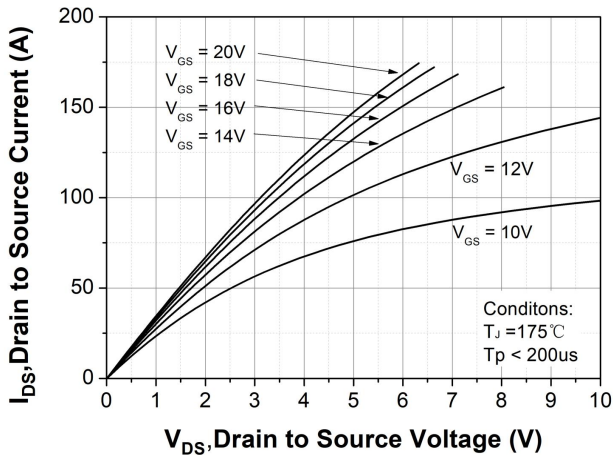


Figure 3. Output Characteristics  $T_J = 175^\circ\text{C}$

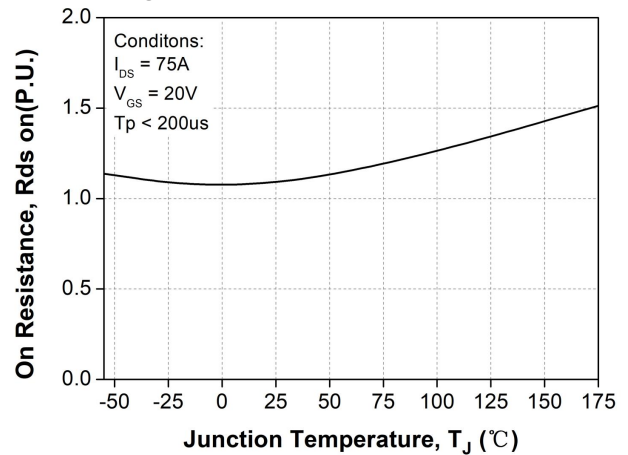


Figure 4. Normalized On-Resistance vs. Temperature

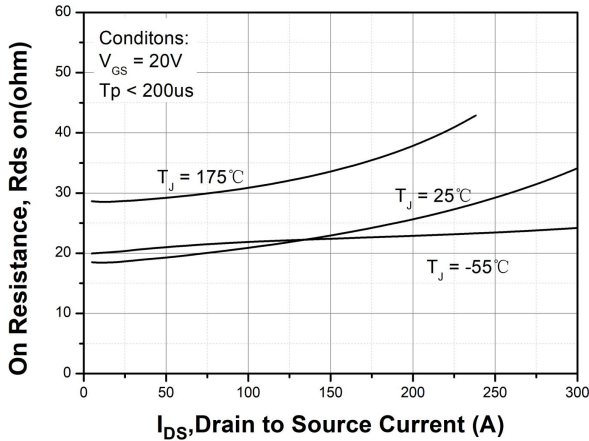


Figure 5. On-Resistance vs. Drain Current For Various Temperatures

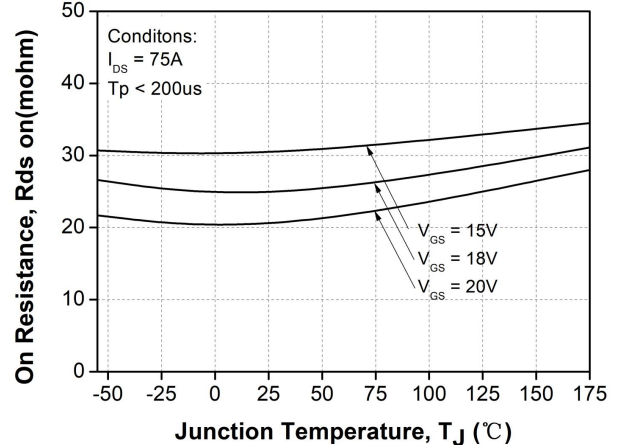


Figure 6. On-Resistance vs. Temperature For Various Gate Voltage

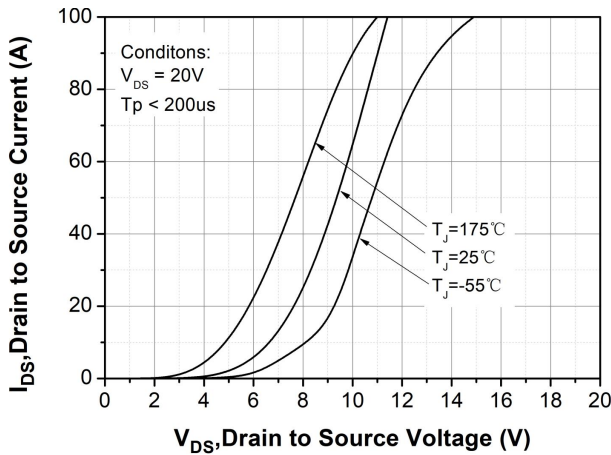


Figure 7. Transfer Characteristic for Various Junction Temperatures

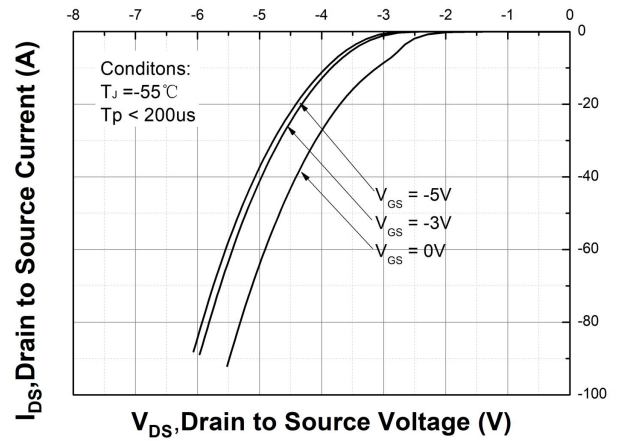


Figure 8. Body Diode Characteristic at  $T_J = -55^\circ C$

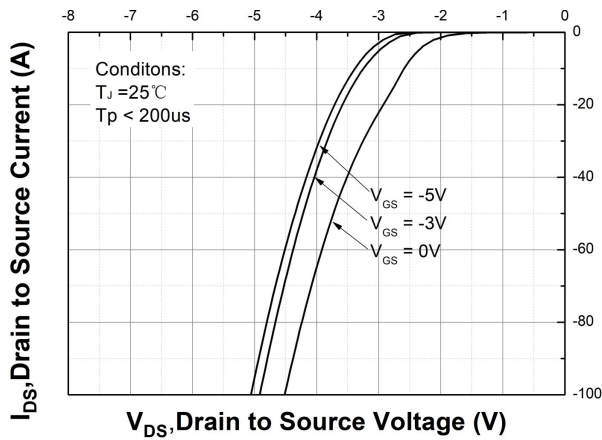


Figure 9. Body Diode Characteristic at  $T_J = 25^\circ C$

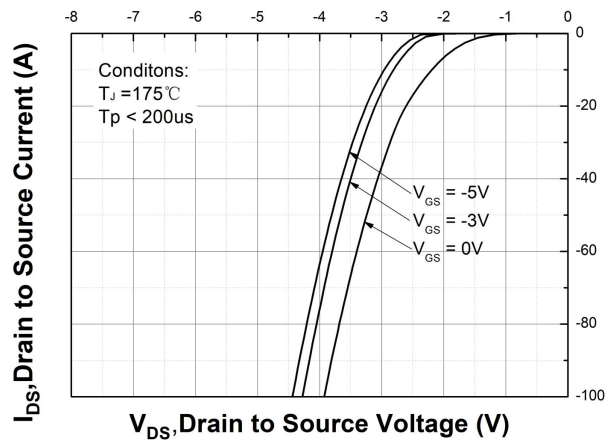


Figure 10. Body Diode Characteristic at  $T_J = 175^\circ C$

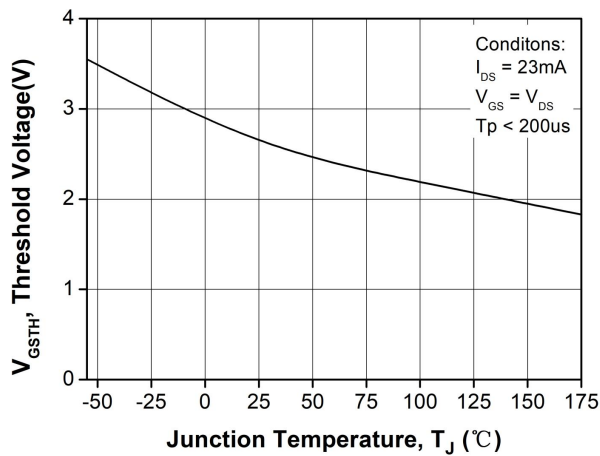


Figure 11. Threshold Voltage vs. Temperature

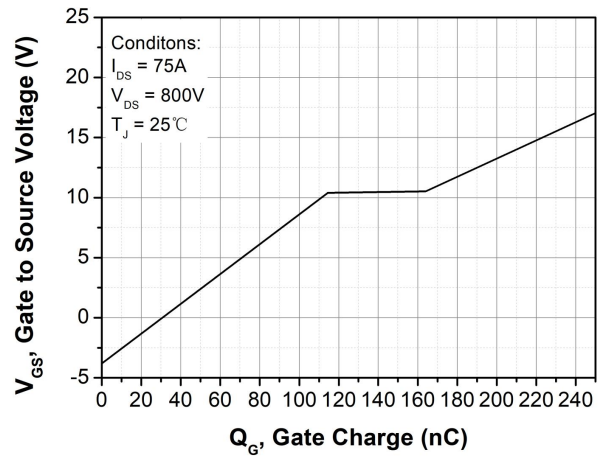
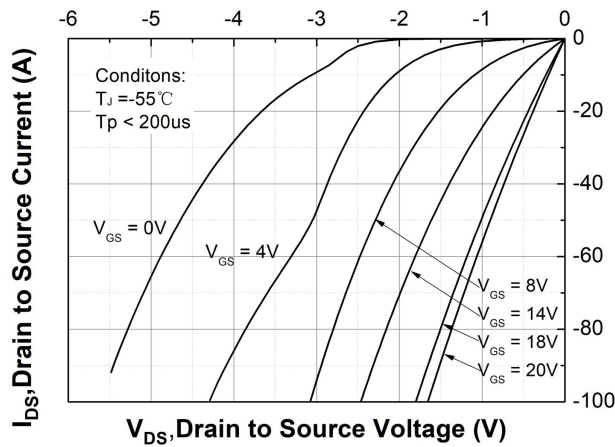
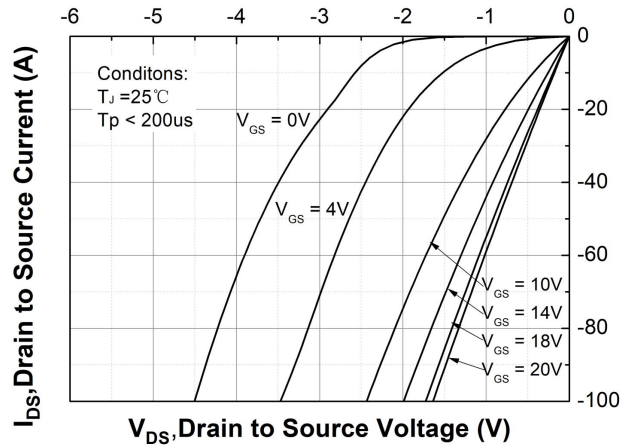


Figure 12. Gate Charge Characteristic

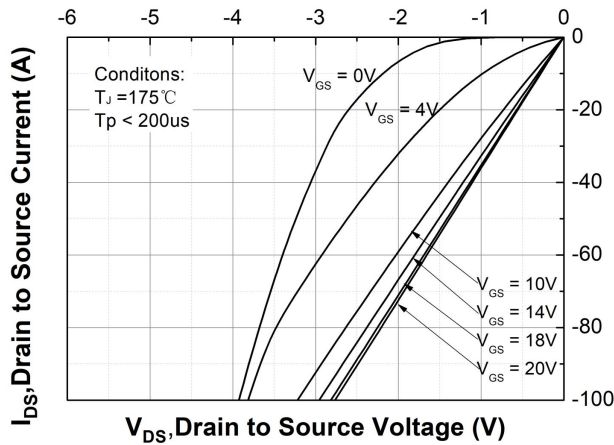
**Technical Data**  
**Data Sheet N2643 REV.-**



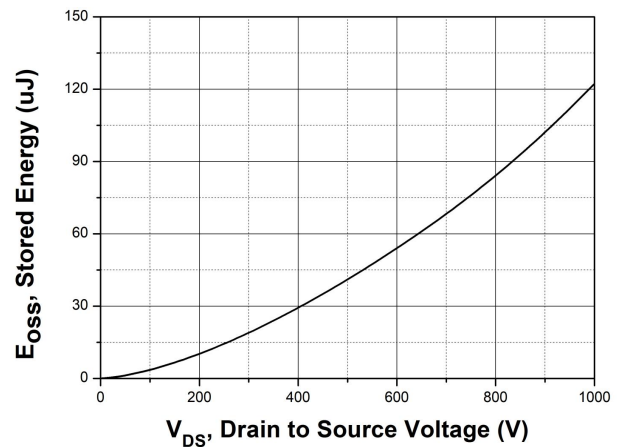
**Figure 13. 3rd Quadrant Characteristic at  $T_J = -55^\circ\text{C}$**



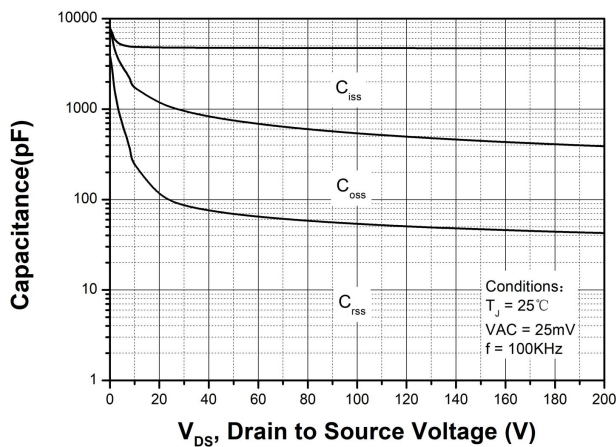
**Figure 14. 3rd Quadrant Characteristic at  $T_J = 25^\circ\text{C}$**



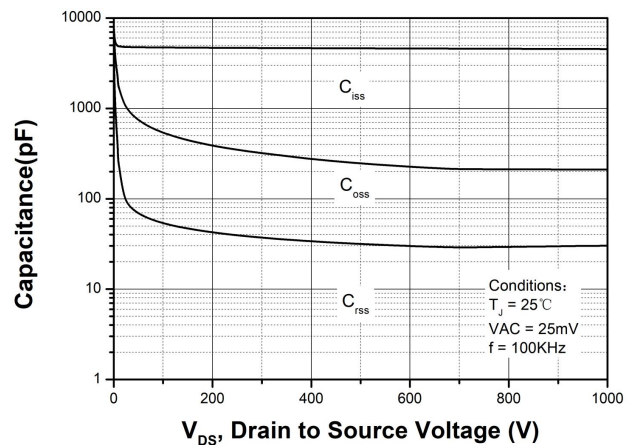
**Figure 15. 3rd Quadrant Characteristic at  $T_J = 175^\circ\text{C}$**



**Figure 16. Output Capacitor Stored Energy**



**Figure 17. Capacitances vs. Drain-Source Voltage (0 - 200V)**



**Figure 18. Capacitances vs. Drain-Source Voltage (0 - 1000V)**

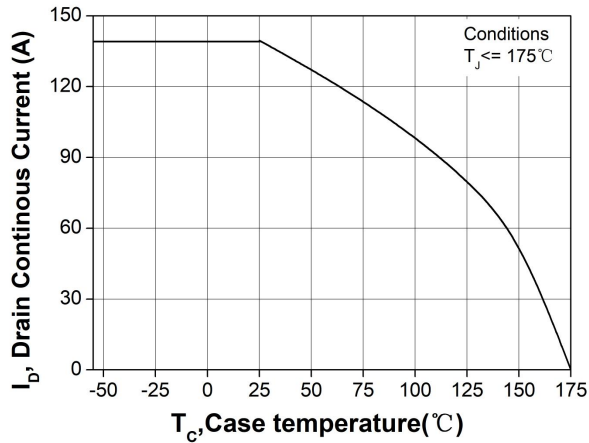


Figure 19. Continuous Drain Current Derating vs. Case Temperature

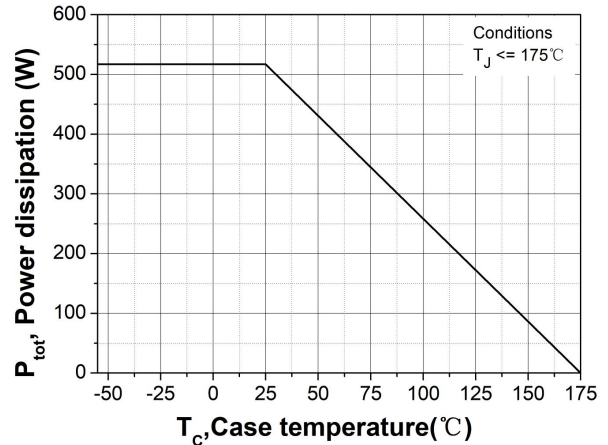


Figure 20. Maximum Power Dissipation Derating vs. Case Temperature

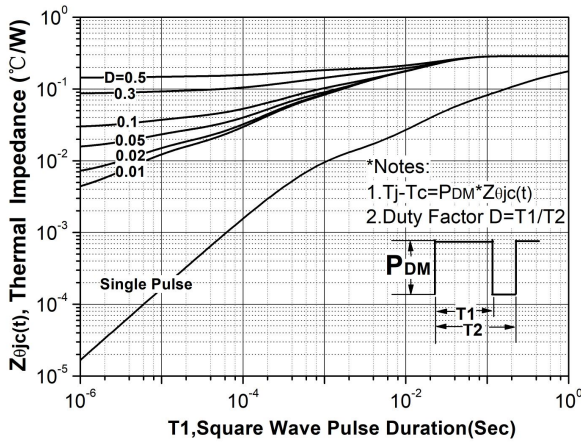


Figure 21. Transient Thermal Impedance (Junction - Case)

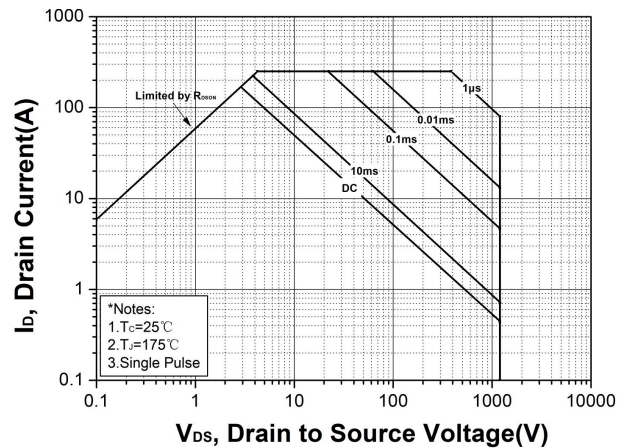


Figure 22. Safe Operating Area

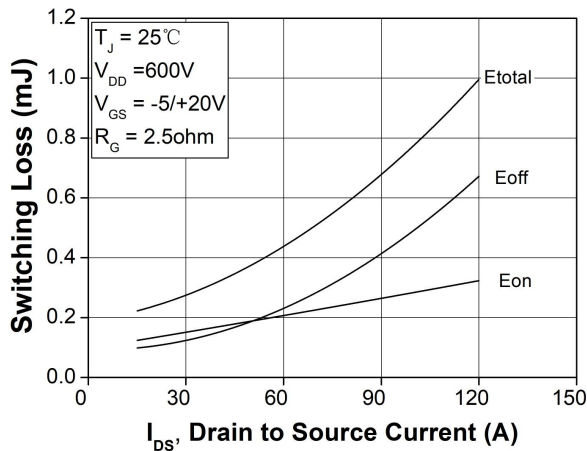


Figure 23. Clamped Inductive Switching Energy vs. Drain Current ( $V_{DD} = 600V$ )

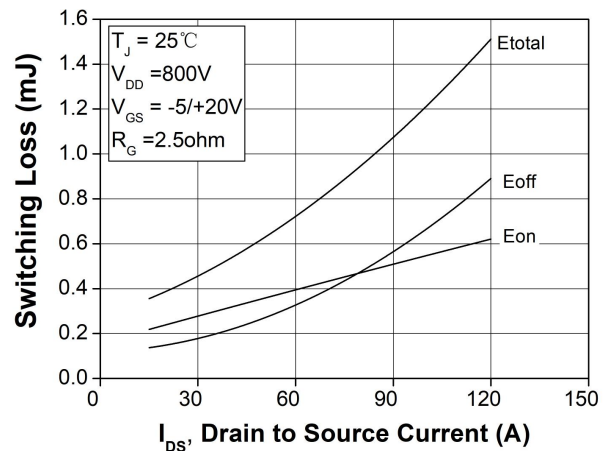


Figure 24. Clamped Inductive Switching Energy vs. Drain Current ( $V_{DD} = 800V$ )

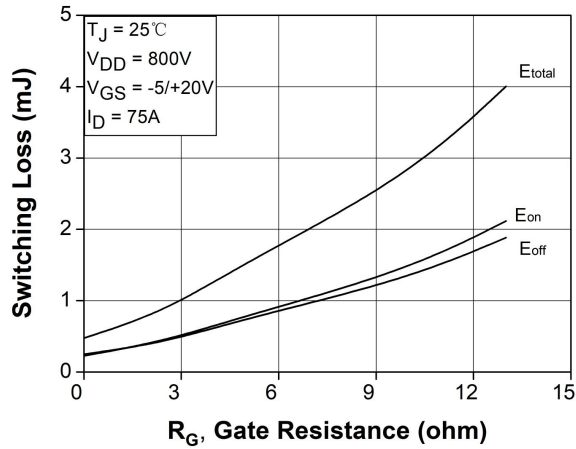


Figure 25. Clamped Inductive Switching Energy vs.  $R_{G(ext)}$

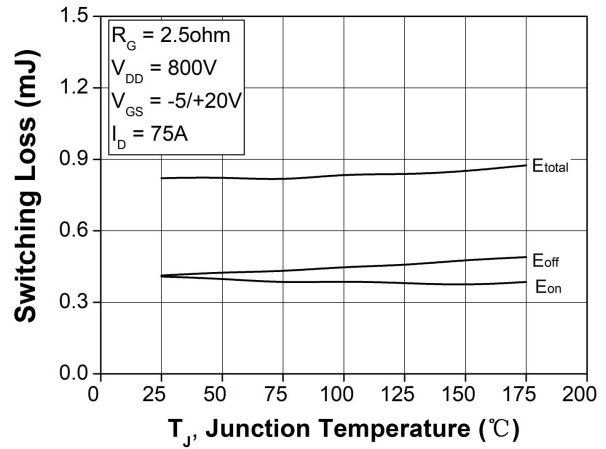


Figure 26. Clamped Inductive Switching Energy vs. Temperature

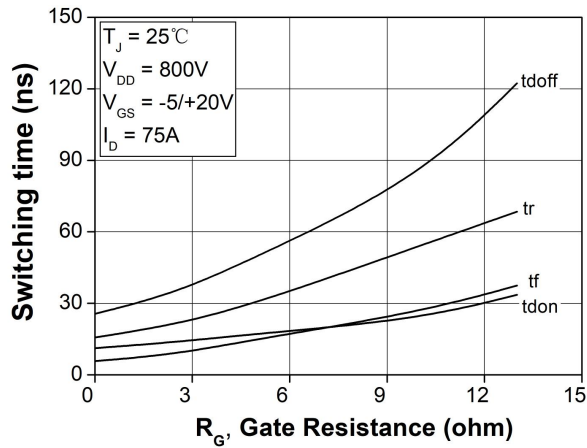


Figure 27. Switching Times vs.  $R_{G(ext)}$

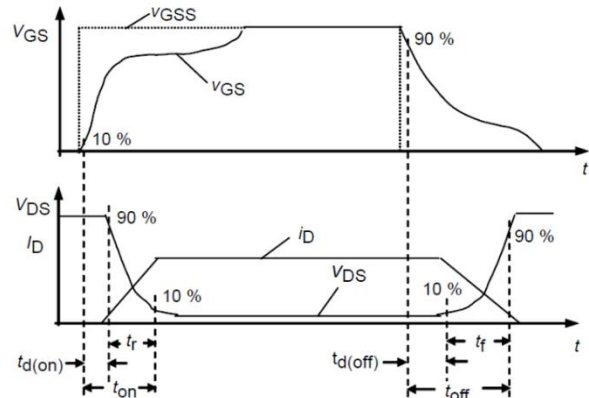
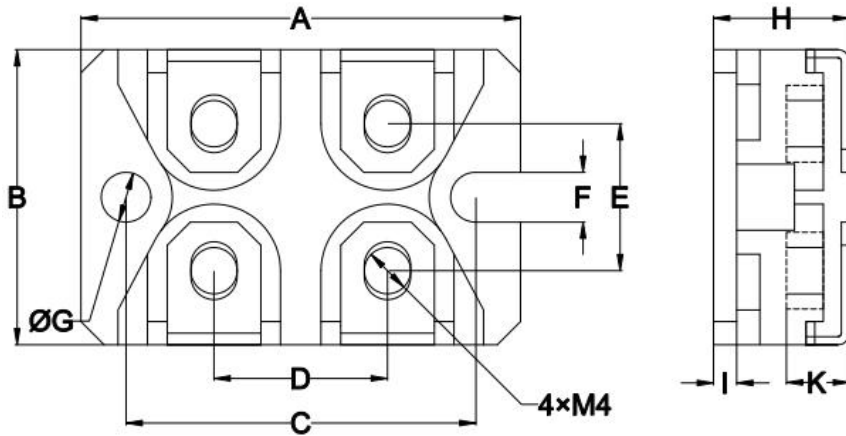


Figure 28. Switching Times Definition



**Mechanical Dimensions SOT-227**



SYMBOL	Dimensions in millimeters	
	Min.	Max.
A	37.8	38.2
B	24.8	25.2
C	29.9	30.5
D	14.5	15.5
E	12.2	13.2
F	4.1	4.31
G	φ4.1	φ4.31
H	11	12.5
I	1.9	2.1
K	4.3	6.5

**Technical Data**  
**Data Sheet N2643 REV.-**

**RoHS**

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